FORM PTO-1449	APPLICATION NO.	CASE NO.
	Unknown	10588-032
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE	ART UNIT
APPLICANT'S INFORMATION DISCLOSURE	Concurrently Herewith	Unknown
STATEMENT		
	APPLICANT(S): James L. Han	ina

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WO01/09665	02/08/2001	Published Appln.		/	
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HP	Emerging NDE Technologies and Challenges at the Beginning of the 3rd MillenniumPart I, Part II, Yoseph Bar-Cohen, January 2000, Vol. 5, No. 1., pages 1-14
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FORM PTO-1449	APPLICATION NO.	CASE NO.
	Unknown	10588-032
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	FILING DATE Concurrently Herewith	ART UNIT Unknown
	APPLICANT(S): James L. Han	ina ·

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INITIAL		NUMBER	DATE	COUNTRY	SUBCLASS	YES	NO
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			<u> </u>	NONE			

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EXAMINER	/Hoa Pham/	DATE CONSIDERED	05/18/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



FORM PTO-1449	APPLICATION NO.	CASE NO.
MADER	10/774,940	10588-032
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE	ART UNIT
APPLICANT'S INFORMATION DISCLOSURE	February 9, 2004	2613
STATEMENT		
	APPLICANT(S): James L. Hanna	

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